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				APPLICANT					
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				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING D. CLASS IF APPROP			
SD	AA	5,646,992	07/08/1997	R. J. SUBLER, et al.					
SD	AB	2002/0078027 A1	06/20/2002	A. A. M. STARING, et al.					
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SD	AO	2 344 925	06/21/2000	GREAT BRITAIN					
SD	AP	WO 03/034425	04/24/2003	WIPO					
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
SD	AA	6,971,024 B1	11/29/2005	Yoichiro SAKO, et al.					
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SD	AO	2002-319932	10/31/2002	Japan (with English Abstract and Uned Computer-Generated English Translation	on)	×			
SD	AP	WO 01/37278 A1	5/25/2001	6.971.024 B1)			×		
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SD	AO	4-163768	06/09/1992	JAPAN (with English Abstract)		ļ		X		
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